

# **CE TEST REPORT**

# FOR

3.5" SATA HDD Single Bay Giga LAN

Model : PD-LN2U2SS, IB-NAS4210-B

Issued to

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1. GENERAL INFORMATION   4     1. DESCRPTION OF THE TESTED SAMPLES   4     1. 21/O PORT OF THE EUT   6     1.3 TEST METHODOLOGY   6     1.4 DESCRPTION OF THE SUPPORT EQUIPMENTS   7     1.5 FEATURES OF EUT   8     2. INSTRUMENT AND CALIBRATION   9     2.1 MEASURNG INSTRUMENT CALIBRATION   9     2.1 MEASURNG INSTRUMENT CALIBRATION   9     2.3 TEST PERFORMED   11     2.4 APPENDIX   12     3. CONDUCTED EMISSION MEASUREMENT   12     3.1 TEST SET-UP   44     3.2 LIMIT   44     3.4 TEST SPECUPICATION   15     3.5 RESULT   15     3.6 TEST DATA   15     3.7 LIMIT OF CONDUCTED COMMON MODE DISTURBANCE AT FELECOMMUNICATION PORTS 17     4.8 RADIATED EMISSION MEASUREMENT   18     4.1 TEST SECUTICATION   15     3.8 RESULT OF CONDUCTED COMMON MODE DISTURBANCE AT FELECOMMUNICATION PORTS 17     4.8 RADIATED EMISSION MEASUREMENT   18     4.1 TEST SECUTICATION   19     4.2 LIMIT   19     4.3 TEST PROCEDURE   19     4.4 TEST SECUTICATION   20	T.	ABL	E OF CONTENTS	- 2
1 2 I/O PORT OF THE FUT   6     3 TEST METHODOLOGY   6     1 4 DESCRIPTION OF THE SUPPORT EQUIPMENTS   7     1 5 FEATURES OF EUT   8     2. INSTRUMENT AND CALIBRATION   9     2. INSTRUMENT AND CALIBRATION   9     2.1 MEASURING INSTRUMENT CALIBRATION   9     2.1 TEST AND MEASUREMENT EQUIPMENT   9     3.1 TEST PERFORMED   11     2.4 APPENDIX   12     3. CONDUCTED EMISSION MEASUREMENT   14     3.1 TEST SPECIFICATION   14     3.2 LINIT   14     3.3 TEST PROCEDURE   14     3.4 TEST SPECIFICATION   15     3.5 RESULT   15     3.6 TEST DATA   15     3.7 LINIT OF CONDUCTED COMMON MODE DISTURBANCE AT TELECOMMUNICATION PORTS -16     3.8 RESULI OF CONDUCTED COMMON MODE DISTURBANCE AT TELECOMMUNICATION PORTS -17     4. RADIATED EMISSION MEASUREMENT   18     4.1 TEST SPECIFICATION   19     4.2 LIMIT OF CONDUCTED COMMON MODE DISTURBANCE AT TELECOMMUNICATION PORTS 17     4.3 RESULT OF CONDUCTED COMMON MODE DISTURBANCE AT TELECOMMUNICATION PORTS -16     3.4 TEST SPECIFICATION   19     4.5 TEST SPECIFICATION   20 </th <th>1.</th> <th>GE</th> <th>ENERAL INFORMATION</th> <th>- 4</th>	1.	GE	ENERAL INFORMATION	- 4
1 2 I/O PORT OF THE FUT   6     3 TEST METHODOLOGY   6     1 4 DESCRIPTION OF THE SUPPORT EQUIPMENTS   7     1 5 FEATURES OF EUT   8     2. INSTRUMENT AND CALIBRATION   9     2. INSTRUMENT AND CALIBRATION   9     2.1 MEASURING INSTRUMENT CALIBRATION   9     2.1 TEST AND MEASUREMENT EQUIPMENT   9     3.1 TEST PERFORMED   11     2.4 APPENDIX   12     3. CONDUCTED EMISSION MEASUREMENT   14     3.1 TEST SPECIFICATION   14     3.2 LINIT   14     3.3 TEST PROCEDURE   14     3.4 TEST SPECIFICATION   15     3.5 RESULT   15     3.6 TEST DATA   15     3.7 LINIT OF CONDUCTED COMMON MODE DISTURBANCE AT TELECOMMUNICATION PORTS -16     3.8 RESULI OF CONDUCTED COMMON MODE DISTURBANCE AT TELECOMMUNICATION PORTS -17     4. RADIATED EMISSION MEASUREMENT   18     4.1 TEST SPECIFICATION   19     4.2 LIMIT OF CONDUCTED COMMON MODE DISTURBANCE AT TELECOMMUNICATION PORTS 17     4.3 RESULT OF CONDUCTED COMMON MODE DISTURBANCE AT TELECOMMUNICATION PORTS -16     3.4 TEST SPECIFICATION   19     4.5 TEST SPECIFICATION   20 </td <td></td> <td>1.1 D</td> <td>ESCRIPTION OF THE TESTED SAMPLES</td> <td>- 4</td>		1.1 D	ESCRIPTION OF THE TESTED SAMPLES	- 4
1.4 DESCRIPTION OF THE SUPPORT EQUIPMENTS   7     1.5 FEATURES OF EUT   8     2. INSTRUMENT AND CALIBRATION   9     2.1 MEASURING INSTRUMENT CALIBRATION   9     2.2 TEST AND MEASUREMENT EQUIPMENT   9     2.3 TEST PERFORMED   11     2.4 APPENDIX   12     3. CONDUCTED EMISSION MEASUREMENT   14     3.1 TEST SET-UP   14     3.2 LIMIT   14     3.3 TEST PROCEDURE   14     3.4 TEST SPECIFICATION   14     3.5 RESULT   14     3.6 TEST DATA   15     3.6 TEST DATA   15     3.6 TEST DATA   15     3.7 LIMIT OF CONDUCTED COMMON MODE DISTURBANCE AT THE ECOMMUNICATION PORTS 17     4. RADIATED EMISSION MEASUREMENT   18     4.1 TEST SETUP   18     4.1 TEST SETUP   18     4.1 TEST SETUP   19     4.3 TEST PROCEDURE   19     4.4 TEST SPECIFICATION   19     4.5 RESULT   20     5.1 TEST SETUP   20     5.1 TEST SETUP   20     5.1 TEST SECUP   20     5.1 TEST SECUP <td< td=""><td></td><td>1.2 I/C</td><td>O PORT OF THE EUT</td><td>- 6</td></td<>		1.2 I/C	O PORT OF THE EUT	- 6
1.5 FFATURES OF EUT   8     2. INSTRUMENT AND CALIBRATION   9     2.1 MEASURING INSTRUMENT CALIBRATION   9     2.2 TEST AND MEASUREMENT EQUIPMENT   9     2.3 TEST PREFORMED   11     2.4 APPENDX   12     3. CONDUCTED EMISSION MEASUREMENT   12     3. CONDUCTED EMISSION MEASUREMENT   14     3.1 TEST SECTICATION   14     3.2 LIMIT   14     3.3 TEST PROCEDURE   14     3.4 TEST SPECIFICATION   15     3.5 RESULT   15     3.6 TEST DATA   15     3.7 LIMIT OF CONDUCTED COMMON MODE DISTURBANCE AT FELECOMMUNICATION PORTS - 16     3.8 RESULT OF CONDUCTED COMMON MODE/DISTURBANCE AT FELECOMMUNICATION PORTS 17     4. RADIATED EMISSION MEASUREMENT   18     4.1 TEST SECUENCATION   19     4.3 TEST PROCEDURE   19     4.4 TEST SPECIFICATION   19     4.5 RESULT   19     4.6 TEST DATA   19     5. FOWER HARMONIC MEASUREMENT   20     5.1 TEST SPECIFICATION   20     5.2 LIMIT PROCEDURE   20     5.3 TEST PROCEDURE   20     5.4 TEST SPEC				
2.   INSTRUMENT AND CALIBRATION   9     2.1   MEASURING INSTRUMENT CALIBRATION   9     2.2   TEST AND MEASUREMENT EQUIPMENT   9     2.3   TEST PERFORMED   11     2.4   APPENDIX   12     3.   CONDUCTED EMISSION MEASUREMENT   14     3.1   TEST SET UP   14     3.2   LIMIT   14     3.3   TEST SPECIFICATION   15     3.5   RESULT   15     3.6   TEST DATA   15     3.7   LIMIT OF CONDUCTED COMMON MODE DISTURBANCE AT TELL COMMUNICATION PORTS 17     4.   RADIATED EMISSION MEASUREMENT   18     4.1   TEST SETUP   18     4.1   TEST SETUP   18     4.2   LIMIT   19     4.3   TEST SPECIFICATION   19     4.4   TEST SPECIFICATION   19     4.5   RESULT   19     4.6   TEST SPECIFICATION   19     4.7   TEST SECIFICATION   20     5.8   POWER HARMONIC CURRENT   20     5.1   TEST SECIFICATION <td></td> <td></td> <td></td> <td></td>				
2.1   MEASURING INSTRUMENT CALIBRATION   9     2.2   TEST AND MEASUREMENT EQUIPMENT   9     2.3   TEST PERFORMED   11     2.4   APPENDIX   12     3.   CONDUCTED EMISSION MEASUREMENT   12     3.1   TEST SET-UP   14     3.2   LIMIT   14     3.3   TEST PROCEDURE   14     3.4   TEST SET-UP   14     3.5   RESULT   14     3.6   TEST PROCEDURE   14     3.7   LIMIT OF CONDUCTED COMMON MODE DISTURBANCE AT TELECOMMUNICATION PORTS -16     3.6   TEST SETUR   15     3.7   LIMIT OF CONDUCTED COMMON MODE DISTURBANCE AT TELECOMMUNICATION PORTS -16     3.8   RESULT OF CONDUCTED COMMON MODE DISTURBANCE AT TELECOMMUNICATION PORTS -16     3.8   RESULT OF CONDUCTED COMMON MODE DISTURBANCE AT TELECOMMUNICATION PORTS -16     4.1   TEST SETUR   18     4.1   TEST SETUR   18     4.1   TEST SETUR   18     4.2   LIMIT   19     3.5   RESULT   19     4.6   TEST PROCEDURE   20		1.5 FE	EATURES OF EUT	- 8
2.1   MEASURING INSTRUMENT CALIBRATION   9     2.2   TEST AND MEASUREMENT EQUIPMENT   9     2.3   TEST PERFORMED   11     2.4   APPENDIX   12     3.   CONDUCTED EMISSION MEASUREMENT   12     3.1   TEST SET-UP   14     3.2   LIMIT   14     3.3   TEST PROCEDURE   14     3.4   TEST SET-UP   14     3.5   RESULT   14     3.6   TEST PROCEDURE   14     3.7   LIMIT OF CONDUCTED COMMON MODE DISTURBANCE AT TELECOMMUNICATION PORTS -16     3.6   TEST SETUR   15     3.7   LIMIT OF CONDUCTED COMMON MODE DISTURBANCE AT TELECOMMUNICATION PORTS -16     3.8   RESULT OF CONDUCTED COMMON MODE DISTURBANCE AT TELECOMMUNICATION PORTS -16     3.8   RESULT OF CONDUCTED COMMON MODE DISTURBANCE AT TELECOMMUNICATION PORTS -16     4.1   TEST SETUR   18     4.1   TEST SETUR   18     4.1   TEST SETUR   18     4.2   LIMIT   19     3.5   RESULT   19     4.6   TEST PROCEDURE   20	2.	IN	STRUMENT AND CALIBRATION	- 9
2.2   TEST AND MEASUREMENT EQUIPMENT   9     2.3   TEST PERFORMED   11     2.4   APPENDIX   12     3.   CONDUCTED EMISSION MEASUREMENT   12     3.1   TEST SET-UP   14     3.2   LIMIT   14     3.3   TEST PROCEDURE   14     3.4   TEST SET-UP   14     3.4   TEST PROCEDURE   14     3.5   RESULT   15     3.6   TEST DATA   15     3.6   TEST DATA   15     3.7   LIMIT OF CONDUCTED COMMON MODE DISTURBANCE AT FELECOMMUNICATION PORTS -16     3.8   RESULT OF CONDUCTED COMMON MODE DISTURBANCE AT FELECOMMUNICATION PORTS -16     3.8   RESULT OF CONDUCTED COMMON MODE DISTURBANCE AT FELECOMMUNICATION PORTS -16     3.8   RESULT OF CONDUCTED COMMON MODE DISTURBANCE AT FELECOMMUNICATION PORTS -17     4.8   A.1   TEST SETUP     4.1   TEST SETUP   18     4.1   TEST SETUP   18     4.2   LIMIT   19     3.5   RESULT   19     4.6   TEST DATA   19 <t< td=""><td></td><td></td><td></td><td>0</td></t<>				0
2.3   TEST PERFORMED   11     2.4   APPENDIX   12     3.   CONDUCTED EMISSION MEASUREMENT   12     3.1   TEST SET-UP   14     3.2   LIMIT   14     3.3   TEST SPECIEDURE   14     3.4   TEST SPECIEDURE   14     3.5   RESULT   15     3.6   TEST SPECIECATION   15     3.7   LIMIT OF CONDUCTED COMMON MODE DISTURBANCE AT TELECOMMUNICATION PORTS -16     3.8   RESULT OF CONDUCTED COMMON MODE DISTURBANCE AT TELECOMMUNICATION PORTS 17     4.   RADIATED EMISSION MEASUREMENT   18     4.1   TEST SETUP   18     4.1   TEST SETUP   18     4.1   TEST SETUP   19     4.4   TEST SETUP   19     4.5   RESULT   19     4.6   TEST DATA   19     4.6   TEST SETUP   20     5.1   TEST SETUP   20     5.1   TEST SETUP   20     5.2   LIMIT OF HARMONIC MEASUREMENT   20     5.3   TEST SETUP   20 </td <td></td> <td></td> <td>MEASURING INSTRUMENT CALIBRATION</td> <td>- 9</td>			MEASURING INSTRUMENT CALIBRATION	- 9
2.4   APPENDIX			TEST AND MEASUREMENT EQUIPMENT	- 9 11
3. CONDUCTED EMISSION MEASUREMENT   14     3.1 TEST SET-UP   14     3.2 LIMIT   14     3.3 TEST PROCEDURE   14     3.4 TEST SPECIFICATION   15     3.5 RESULT   15     3.6 TEST SPECIFICATION   15     3.7 LIMIT OF CONDUCTED COMMON MODE DISTURBANCE AT FELECOMMUNICATION PORTS16     3.8 RESULT OF CONDUCTED COMMON MODE DISTURBANCE AT FELECOMMUNICATION PORTS16     3.8 RESULT OF CONDUCTED COMMON MODE DISTURBANCE AT FELECOMMUNICATION PORTS16     3.8 RESULT OF CONDUCTED COMMON MODE DISTURBANCE AT FELECOMMUNICATION PORTS16     4.1 TEST SETUP   18     4.1 TEST SECUP   19     4.3 TEST PROCEDURE   19     4.4 TEST SPECIFICATION   19     4.5 RESULT   19     4.6 TEST DATA   19     5. POWER HARMONIC MEASUREMENT   20     5.1 TEST SETUP   20     5.2 LIMIT OF HARMONIC MEASUREMENT   20     5.1 TEST SETUP   20     5.2 LIMIT OF HARMONIC MEASUREMENT   20     5.4 TEST SPECIFICATION   20     5.5 RESULT   20     5.6 TEST DATA   20     5.7 OVITAGE FLUCTUATIONS TEST   23 </td <td></td> <td></td> <td>APPENDIX</td> <td></td>			APPENDIX	
3.1   TEST SET-UP   14     3.2   LIMIT   14     3.3   TEST PROCEDURE   14     3.4   TEST SPECIFICATION   15     3.5   RESULT   15     3.6   TEST DATA   15     3.7   LIMIT OF CONDUCTED COMMON MODE DISTURBANCE AT THE ECOMMUNICATION PORTS - 16     3.8   RESULT OF CONDUCTED COMMON MODE DISTURBANCE AT THE ECOMMUNICATION PORTS - 16     3.8   RESULT OF CONDUCTED COMMON MODE DISTURBANCE AT THE ECOMMUNICATION PORTS - 16     3.8   RESULT OF CONDUCTED COMMON MODE DISTURBANCE AT THE ECOMMUNICATION PORTS - 16     3.8   RESULT OF CONDUCTED COMMON MODE DISTURBANCE AT THE ECOMMUNICATION PORTS - 16     4.8   RESULT   19     4.1   TEST SETUP   18     4.2   LIMIT   19     4.4   TEST SPECIFICATION   19     4.5   RESULT   19     4.6   TEST DATA   19     5.1   TEST SETUP   20     5.1   TEST SETUP   20     5.2   LIMIT OF HARMONIC MEASUREMENT   20     5.4   TEST SPECIFICATION   20     5.5   RESULT	_			
3.2   LIMIT   14     3.3   TEST PROCEDURE   14     3.4   TEST SPECIFICATION   15     3.5   RESULT   15     3.6   TEST DATA   15     3.7   LIMIT OF CONDUCTED COMMON MODE DISTURBANCE AT TELECOMMUNICATION PORTS16     3.8   RESULT OF CONDUCTED COMMON MODE DISTURBANCE AT TELECOMMUNICATION PORTS16     3.8   RESULT OF CONDUCTED COMMON MODE DISTURBANCE AT TELECOMMUNICATION PORTS16     4.1   TEST SETUP	3.	CC		14
3.3   TEST PROCEDURE   14     3.4   TEST SPECIFICATION   15     3.5   RESULT   15     3.6   TEST DATA   15     3.6   TEST DATA   15     3.7   LIMIT OF CONDUCTED COMMON MODE DISTURBANCE AT TELECOMMUNICATION PORTS -16     3.8   RESULT OF CONDUCTED COMMON MODE DISTURBANCE AT TELECOMMUNICATION PORTS -16     3.8   RESULT OF CONDUCTED COMMON MODE DISTURBANCE AT TELECOMMUNICATION PORTS -17     4.   RADIATED EMISSION MEASUREMENT     4.   RADIATED EMISSION MEASUREMENT     4.1   TEST SPECIFICATION     4.2   LIMIT     4.3   TEST PROCEDURE     4.4   TEST SPECIFICATION     4.5   RESULT     4.6   TEST DATA     9   4.6     5.1   TEST SETUP     4.6   TEST DATA     9   5.     6.1   TEST SETUP     2.2   LIMIT OF HARMONIC CURRENT   20     5.4   TEST SPECIFICATION   20     5.5   RESULT   20     5.6   TEST SPECIPLOR   20     5.6 <td></td> <td>3.1</td> <td></td> <td>14</td>		3.1		14
3.4   TEST SPECIFICATION   15     3.5   RESULT   15     3.6   TEST DATA   15     3.7   LIMIT OF CONDUCTED COMMON MODE DISTURBANCE AT TELECOMMUNICATION PORTS -16     3.8   RESULT OF CONDUCTED COMMON MODE DISTURBANCE AT TELECOMMUNICATION PORTS 17     4.   RADIATED EMISSION MEASUREMENT   18     4.1   TEST SETUP   18     4.2   LIMIT   19     4.3   TEST PROCEDURE   19     4.4   TEST SPECIFICATION   19     4.5   RESULT   19     4.6   TEST DATA   19     5.   POWER HARMONIC MEASUREMENT   20     5.1   TEST SETUP   20     5.2   LIMIT OF HARMONIC CURRENT   20     5.3   TEST PROCEDURE   20     5.4   TEST SECIFICATION   20     5.5   RESULT   20     5.6   TEST DATA   20     5.6   TEST DATA   20     5.6   TEST DATA   20     5.6   TEST DATA   20     5.7   TEST SETUP   20		3.2	LIMIТ	14
3.4   TEST SPECIFICATION   15     3.5   RESULT   15     3.6   TEST DATA   15     3.7   LIMIT OF CONDUCTED COMMON MODE DISTURBANCE AT TELECOMMUNICATION PORTS -16     3.8   RESULT OF CONDUCTED COMMON MODE DISTURBANCE AT TELECOMMUNICATION PORTS 17     4.   RADIATED EMISSION MEASUREMENT   18     4.1   TEST SETUP   18     4.2   LIMIT   19     4.3   TEST PROCEDURE   19     4.4   TEST SPECIFICATION   19     4.5   RESULT   19     4.6   TEST DATA   19     5.   POWER HARMONIC MEASUREMENT   20     5.1   TEST SETUP   20     5.2   LIMIT OF HARMONIC CURRENT   20     5.3   TEST PROCEDURE   20     5.4   TEST SECIFICATION   20     5.5   RESULT   20     5.6   TEST DATA   20     5.6   TEST DATA   20     5.6   TEST DATA   20     5.6   TEST DATA   20     5.7   TEST SETUP   20		3.3	TEST PROCEDURE	14
3.6   TEST DATA		3.4	TEST SPECIFICATION	
3.7   LIMIT OF CONDUCTED COMMON MODE DISTURBANCE AT TELECOMMUNICATION PORTS -16     3.8   RESULT OF CONDUCTED COMMON MODE DISTURBANCE AT TELECOMMUNICATION PORTS 17     4. <b>RADIATED EMISSION MEASUREMENT</b> 4. <b>RADIATED EMISSION MEASUREMENT</b> 4.1   TEST SPECIFICATION     4.2   LIMIT     4.3   TEST SPECIFICATION     4.4   TEST SPECIFICATION     4.5   RESULT     4.6   TEST DATA     19   4.6     5. <b>POWER HARMONIC MEASUREMENT</b> 20   5.1     5.1   TEST SPECIFICATION     20   5.2     5.4   TEST SPECIFICATION     20   5.4     5.4   TEST SPECIFICATION     20   5.5     5.6   TEST DATA     200   5.6     5.6   TEST DATA     200   5.6     5.6   TEST DATA     20   5.6     5.6   TEST DATA     20   5.6     5.6   TEST DATA     20   5.6     5.7   TE			Result	
3.8   RESULT OF CONDUCTED COMMON MODE DISTURBANCE AT FÉLECOMMUNICATION PORTS 17     4.   RADIATED EMISSION MEASUREMENT				
4. RADIATED EMISSION MEASUREMENT   18     4.1 TEST SETUP   18     4.2 LIMIT   19     4.3 TEST PROCEDURE   19     4.4 TEST SPECIFICATION   19     4.5 RESULT   19     4.6 TEST DATA   19     5. POWER HARMONIC MEASUREMENT   20     5.1 TEST SECUP   20     5.2 LIMIT OF HARMONIC CURRENT   20     5.3 TEST PROCEDURE   20     5.4 TEST SECUFICATION   20     5.5 RESULT   20     5.6 TEST DATA   20     5.6 TEST SECUFICATION   20     5.6 TEST DATA   20     5.7 RESULT   23     6.1 TEST SETUP   23     6.2 VOLTAGE FLUCTUATIONS TEST   23     6.3 RESILT   23     6.4 TEST SPECUFICATION   23     6.5				
4.1   TEST SETUP   18     4.2   LIMIT   19     4.3   TEST PROCEDURE   19     4.4   TEST SPECIFICATION   19     4.5   RESULT   19     4.6   TEST DATA   19     5.   POWER HARMONIC MEASUREMENT   20     5.1   TEST DATA   20     5.2   LIMIT OF HARMONIC CURRENT   20     5.3   TEST PROCEDURE   20     5.4   TEST SPECIFICATION   20     5.5   RESULT   20     5.6   TEST DATA   20     5.6   TEST DATA   20     6.6   VOLTAGE FLUCTUATIONS   20     5.6   TEST SETUP   20     5.6   TEST DATA   20     6.6   VOLTAGE FLUCTUATIONS TEST   20     6.7   VOLTAGE FLUCTUATIONS TEST   23     6.8   TEST DATA   23     6.4   TEST SPECIFICATION   23     6.5   RESULT   23     6.6   TEST DATA   23     6.7   TEST SPECIFICATION <t< td=""><td></td><td>3.8</td><td></td><td></td></t<>		3.8		
4.2   LIMIT   19     4.3   TEST PROCEDURE   19     4.4   TEST SPECIFICATION   19     4.5   RESULT   19     4.6   TEST DATA   19     5.   POWER HARMONIC MEASUREMENT   20     5.1   TEST SETUP   20     5.2   LIMIT OF HARMONIC CURRENT   20     5.3   TEST PROCEDURE   20     5.4   TEST SPECIFICATION   20     5.5   RESULT   20     5.6   TEST DATA   20     6.4   TEST SETUP   20     6.5   TEST PROCEDURE   20     5.6   TEST DATA   20     6.4   TEST SETUP   20     6.5   TEST UP   23     6.1   TEST SETUP   23     6.2   VOLTAGE FLUCTUATIONS TEST   23     6.3   TEST PROCEDURE   23     6.4   TEST SPECIFICATION   23     6.5   RESULT   23     6.6   TEST DATA   23     7.   ELECTROSTATIC DISCHARGE IMMUNITY TEST (ESD)	4.	RA	ADIA TED EMISSION MEASUREMENT	18
4.2   LIMIT   19     4.3   TEST PROCEDURE   19     4.4   TEST SPECIFICATION   19     4.5   RESULT   19     4.6   TEST DATA   19     5.   POWER HARMONIC MEASUREMENT   20     5.1   TEST SETUP   20     5.2   LIMIT OF HARMONIC CURRENT   20     5.3   TEST PROCEDURE   20     5.4   TEST SPECIFICATION   20     5.5   RESULT   20     5.6   TEST DATA   20     6.4   TEST SETUP   20     6.5   TEST PROCEDURE   20     5.6   TEST DATA   20     6.4   TEST SETUP   20     6.5   TEST UP   23     6.1   TEST SETUP   23     6.2   VOLTAGE FLUCTUATIONS TEST   23     6.3   TEST PROCEDURE   23     6.4   TEST SPECIFICATION   23     6.5   RESULT   23     6.6   TEST DATA   23     7.   ELECTROSTATIC DISCHARGE IMMUNITY TEST (ESD)		11		10
4.4   TEST SPECIFICATION   19     4.5   RESULT   19     4.6   TEST DATA   19     5. <b>POWER HARMONIC MEASUREMENT</b> 20     5.1   TEST SETUP   20     5.2   LIMIT OF HARMONIC CURRENT   20     5.3   TEST PROCEDURE   20     5.4   TEST SPECIFICATION   20     5.5   RESULT   20     5.6   TEST DATA   20     5.6   TEST DATA   20     6.1   TEST SETUP   20     6.2   VOLTAGE FLUCTUATIONS TEST   20     6.3   TEST PROCEDURE   23     6.4   TEST SPECIFICATION   23     6.5   RESULT   23     6.4   TEST SPECIFICATION   23     6.5   RESULT   23     6.6   TEST DATA   23     7.   ELECTROSTATIC DISCHARGE IMMUNITY TEST (ESD)   23     7.   ELECTROSTATIC DISCHARGE IMMUNITY TEST (ESD)   25     7.1   TEST SETUP   25     7.2   TEST SETUP   25 <t< td=""><td></td><td></td><td>I MIT</td><td>10</td></t<>			I MIT	10
4.4   TEST SPECIFICATION   19     4.5   RESULT   19     4.6   TEST DATA   19     5. <b>POWER HARMONIC MEASUREMENT</b> 20     5.1   TEST SETUP   20     5.2   LIMIT OF HARMONIC CURRENT   20     5.3   TEST PROCEDURE   20     5.4   TEST SPECIFICATION   20     5.5   RESULT   20     5.6   TEST DATA   20     5.6   TEST DATA   20     6.1   TEST SETUP   20     6.2   VOLTAGE FLUCTUATIONS TEST   20     6.3   TEST PROCEDURE   23     6.4   TEST SPECIFICATION   23     6.5   RESULT   23     6.4   TEST SPECIFICATION   23     6.5   RESULT   23     6.6   TEST DATA   23     7.   ELECTROSTATIC DISCHARGE IMMUNITY TEST (ESD)   23     7.   ELECTROSTATIC DISCHARGE IMMUNITY TEST (ESD)   25     7.1   TEST SETUP   25     7.2   TEST SETUP   25 <t< td=""><td></td><td></td><td>Test Procedure</td><td>19</td></t<>			Test Procedure	19
4.6   TEST DATA   19     5.   POWER HARMONIC MEASUREMENT   20     5.1   TEST SETUP   20     5.2   LIMIT OF HARMONIC CURRENT   20     5.3   TEST PROCEDURE   20     5.4   TEST SPECIFICATION   20     5.5   RESULT   20     5.6   TEST DATA   20     6.   VOLTAGE FLUCTUATIONS   20     6.1   TEST SETUP   20     6.2   VOLTAGE FLUCTUATIONS TEST   23     6.3   FEST PROCEDURE   23     6.4   TEST SPECIFICATION   23     6.4   TEST SPECIFICATION   23     6.5   RESULT   23     6.6   TEST DATA   23     6.6   TEST DATA   23     6.6   TEST DATA   23     7.   ELECTROSTATIC DISCHARGE IMMUNITY TEST (ESD)   25     7.1   TEST PROCEDURE   25     7.2   TEST SETUP   25     7.3   TEST LEVEL   25			TEST SPECIFICATION	19
4.6   TEST DATA   19     5.   POWER HARMONIC MEASUREMENT   20     5.1   TEST SETUP   20     5.2   LIMIT OF HARMONIC CURRENT   20     5.3   TEST PROCEDURE   20     5.4   TEST SPECIFICATION   20     5.5   RESULT   20     5.6   TEST DATA   20     6.   VOLTAGE FLUCTUATIONS   20     6.1   TEST SETUP   20     6.2   VOLTAGE FLUCTUATIONS TEST   23     6.3   FEST PROCEDURE   23     6.4   TEST SPECIFICATION   23     6.4   TEST SPECIFICATION   23     6.5   RESULT   23     6.6   TEST DATA   23     6.6   TEST DATA   23     6.6   TEST DATA   23     7.   ELECTROSTATIC DISCHARGE IMMUNITY TEST (ESD)   25     7.1   TEST PROCEDURE   25     7.2   TEST SETUP   25     7.3   TEST LEVEL   25			Result	19
5.   POWER HARMONIC MEASUREMENT   20     5.1   TEST SETUP   20     5.2   LIMIT OF HARMONIC CURRENT   20     5.3   TEST PROCEDURE   20     5.4   TEST SPECIFICATION   20     5.5   RESULT   20     5.6   TEST DATA   20     6.   VOLTAGE FLUCTUATIONS   23     6.1   TEST SETUR   23     6.2   VOLTAGE FLUCTUATIONS TEST   23     6.3   TEST PROCEDURE   23     6.4   TEST SECIFICATION   23     6.5   RESULT   23     6.6   TEST DATA   23     6.6   TEST SPECIFICATION   23     6.6   TEST SPECIFICATION   23     6.6   TEST DATA   23     7.   ELECTROSTATIC DISCHARGE IMMUNITY TEST (ESD)   25     7.1   TEST PROCEDURE   25     7.2   TEST SETUP   25     7.3   TEST LEVEL   25		4.6	Теят Дата	19
5.1   TEST SETUP   20     5.2   LIMIT OF HARMONIC CURRENT   20     5.3   TEST PROCEDURE   20     5.4   TEST SECIFICATION   20     5.5   RESULT   20     5.6   TEST DATA   20     6.   VOLTAGE FLUCTUATIONS   23     6.1   TEST SETUR   23     6.2   VOLTAGE FLUCTUATIONS TEST   23     6.3   TEST SETUR   23     6.4   TEST SPECIFICATION   23     6.5   RESULT   23     6.4   TEST SPECIFICATION   23     6.5   RESULT   23     6.6   TEST DATA   23     7.   ELECTROSTATIC DISCHARGE IMMUNITY TEST (ESD)   25     7.1   TEST PROCEDURE   25     7.2   TEST SETUP   25     7.3   TEST LEVEL   25	5	PO		
5.2   LIMIT OF HARMONIC CURRENT   20     5.3   TEST PROCEDURE   20     5.4   TEST SPECIFICATION   20     5.5   RESULT   20     5.6   TEST DATA   20     6.   VOLTAGE FLUCTUATIONS   23     6.1   TEST SETUP   23     6.2   VOLTAGE FLUCTUATIONS TEST   23     6.3   TEST PROCEDURE   23     6.4   TEST SPECIFICATION   23     6.5   RESULT   23     6.6   TEST SPECIFICATION   23     6.7   TEST SPECIFICATION   23     6.8   TEST SPECIFICATION   23     6.4   TEST SPECIFICATION   23     6.5   RESULT   23     6.6   TEST DATA   23     7.6   ELECTROSTATIC DISCHARGE IMMUNITY TEST (ESD)   25     7.1   TEST PROCEDURE   25     7.2   TEST SETUP   25     7.3   TEST LEVEL   25	5.			
5.3   TEST PROCEDURE   20     5.4   TEST SPECIFICATION   20     5.5   RESULT   20     5.6   TEST DATA   20     6.   VOLTAGE FLUCTUATIONS   23     6.1   TEST SETUP   23     6.2   VOLTAGE FLUCTUATIONS TEST   23     6.3   FEST PROCEDURE   23     6.4   TEST SPECIFICATION   23     6.5   RESULT   23     6.6   TEST DATA   23     7.   ELECTROSTATIC DISCHARGE IMMUNITY TEST (ESD)   25     7.1   TEST PROCEDURE   25     7.2   TEST SETUP   25     7.3   TEST LEVEL   25				
5.4   TEST SPECIFICATION			LIMIT OF HARMONIC CURRENT	20
5.5   RESULT			TEST PROCEDURE	20
5.6   TEST DATA   20     6.   VOLTAGE FLUCTUATIONS   23     6.1   TEST SETUP   23     6.2   VOLTAGE FLUCTUATIONS TEST   23     6.3   TEST PROCEDURE   23     6.4   TEST SPECIFICATION   23     6.5   RESULT   23     6.6   TEST DATA   23     7.   ELECTROSTATIC DISCHARGE IMMUNITY TEST (ESD)   25     7.1   TEST PROCEDURE   25     7.2   TEST SETUP   25     7.3   TEST LEVEL   25				
6.   VOLTAGE FLUCTUATIONS   23     6.1   TEST SETUR				
6.1   TEST SETUR   23     6.2   VOLTAGE FLUCTUATIONS TEST   23     6.3   TEST PROCEDURE   23     6.4   TEST SPECIFICATION   23     6.5   RESULT   23     6.6   TEST DATA   23     7.   ELECTROSTATIC DISCHARGE IMMUNITY TEST (ESD)   25     7.1   TEST PROCEDURE   25     7.2   TEST SETUP   25     7.3   TEST LEVEL   25				
6.2   VOLTAGE FLUCTUATIONS TEST	6.	VC	DLTAGE FLUCTUATIONS	23
6.2   VOLTAGE FLUCTUATIONS TEST		61	TEST SETUP	23
6.3   TEST PROCEDURE				
6.4   TEST SPECIFICATION				
6.6   TEST DATA				
7. ELECTROSTATIC DISCHARGE IMMUNITY TEST (ESD)   25     7.1 TEST PROCEDURE   25     7.2 TEST SETUP   25     7.3 TEST LEVEL   25		6.5	Result	23
7.1   TEST PROCEDURE25     7.2   TEST SETUP25     7.3   TEST Level25		6.6	Теят Дата	23
7.2   TEST SETUP25     7.3   TEST LEVEL25	7.	EL	LECTROSTATIC DISCHARGE IMMUNITY TEST (ESD)	25
7.2   TEST SETUP25     7.3   TEST LEVEL25				
7.3 TEST LEVEL25				



8.	RADIATED EMISSION MEASUREMENT(RS)	27
8	3.1 TEST SETUP	27
	3.2 TEST PROCEDURE	
	3.3 TEST LEVEL	
	8.4 TEST PROCEDURE	
	3.5 TEST RESULT	
9.	ELECTRICAL FAST TRANSIENT/BURST (EFT)	
	0.1 Test Setup	
-	0.2 TEST PROCEDURE	
-		29
9 10.		30 31
	0.1 TEST SETUP	31
		31
	0.3 TEST LEVEL	31
-		32
1	0.5 TEST RESULT	32
11.	IMMUNITY TEST TO CS CONDUCTED DISTURBANCE (CS)	33
1	1.1 TEST SETUP	33
	1.2 TEST PROCEDURE	33
	1.3 TEST LEVEL	33
	1.4 TEST PROCEDURE	33
	11.5 TEST RESULT	
		-
12.		
1	2.1 TEST SETUP	35
1	2.2 TEST STANDARD	35
1	2.3 TEST LEVEL	35
1	2.4 TEST PROCEDURE	35
1	2.5 TEST RESULT	36
13.	VOLTAGE DIPS AND INTERRUPTION MEASUREMENT	
1	3.1 Test setup	
	3.2 TEST PROCEDURE	
	3.3 TEST LEVEL	
	3.4 TEST PROCEDURE	
	3.5 TEST RESULT	
	PERFORMANCE CRITERIA	
14.	TERFORMANCE UKITERIA	40
15.	MODIFICATION LIST FOR EMC COMPLYING TEST	41
AP	PPENDIX 1	

PHOTOS OF TEST CONFIGURATION

**APPENDIX 2** 

TEST DATA

PHOTOS OF EUT



# **1. GENERAL INFORMATION**

Applicant	:	Macpower & Tytech Technology Co., Ltd.
Address	:	8F, No. 52, MinQuan Road Hsintien City, Taipei 231, Taiwan R.O.C.
Manufacturer	:	Macpower & Tytech Technology Co., Ltd.
Address	:	8F, No. 52, MinQuan Road Hsintien City, Taipei 231, Taiwan R.O.C.
EUT	:	3.5" SATA HDD Single Bay Giga LAN
Model Name	:	PD-LN2U2SS, IB-NAS4210-B
Model Differences	:	The difference between series of models PD-LN2U2SS and IB-NAS4210-B is different software and market, but the PCB layout is same, the EMI characteristic is same. The model PD-LN2U2SS is testing sample and the final test data were shown in this test report.

Measurement procedure used:

EMI :

EN55022 CLASS B:2006

EN61000-3-2:2006

EN61000-3-3:1995+A1:2001+A2:2005

EMS : EN55024:1998+A1:2001+A2:2003 IEC 61000-4-2 : 2001 IEC 61000-4-3 : 2008 IEC 61000-4-3 : 2004 IEC 61000-4-5 : 2005 IEC 61000-4-6 : 2008 IEC 61000-4-8 : 2001 IEC 61000-4-11 : 2004

# **Deviation from Applicable Standard**

According to applicants declaration this EUT is a class B product

The above equipment was tested by Global Certification Corp. for compliance with the requirements set forth in the EUROPEAN COUNCIL Directive 2004/108/EC and the technical standards mentioned above. The results of testing in this report apply only to the product/system, which was tested. Other similar equipment will not necessarily produce the same results due to production tolerance.

This test report shall not be reproducing in part without written approval of Global Certification Corp.

**Approved By:** 

Alex Chou / Manager

Issued Date:03.03.2009



# **1.1 DESCRIPTION OF THE TESTED SAMPLES**

EUT		
EUT Type	:	☑Engineer Type
Condition when received	:	☑Good □Damage :
EUT Name	:	3.5" SATA HDD Single Bay Giga LAN
Applicant	:	Macpower & Tytech Technology Co., Ltd.
Manufacturer	:	Macpower & Tytech Technology Co., Ltd.
Model Number	:	PD-LN2U2SS, IB-NAS4210-B
Serial Number	:	N/A
FCC ID	:	N/A
Receipt Date	:	02/25/2009
Used Power	:	☑AC POWER □DC POWER
Power Supply Type	:	☑Switching □Linear □ N/A
Power Cord (Input)	:	⊠AC <u>230</u> V <u>50</u> Hz <u>2</u> Pin <u>0</u> m Un-Shielded □ N/A
Power Cord (Output)	:	☑DC <u>12</u> V <u>2</u> Pin <u>15</u> m Un-Shielded □ N/A
Power From		□N/A □Inside ☑Outside
		□N/A ☑Adaptor □BATTERY □Power Supply □DC Power Source □Support Unit PC □AC Power Source
Test Power		☑AC POWER □DC POWER <u>230</u> V <u>50</u> Hz <u>2</u> Pin <u>0</u> m
The frequency of the EUT	:	
OSC/Clock Frequencies	Ż	60MHz, 25MHz



#### **1.2 I/O PORT OF THE EUT**

I/O port type	Q'ty	Tested with	Connect type	Note
1) LAN Port	1	1	Metal	
2) USB Port	2	2	Metal	

#### **1.3 TEST METHODOLOGY**

#### EUT SYSTEM OPERATION

- 1. The EUT was configured according to EN55022 Class B
- 2. All I/O ports were connected to the appropriate peripherals.
- 3. Photos of test configuration please refer to appendix 1 or 1.4 Setup Diagram.
- 4. Turn on all the power of EUT and peripheral.
- 5. EUT executes "winthrax.exe to active read-write function under windows.
- 6. During the test, the EUT was sending data to the PC connected via USB port.
- 7. Perform the EMI testing procedures, and measure the maximum emission noise.
- All peripherals and cables are listed below (including internal device)

# DECISION OF FINAL TEST MODE

1. The following test mode were scanned during the preliminary test:

Mode 1: USB

Mode 2: LAN

2. After the preliminary scan, the following test mode was found to produce the highest emission level.

Conduction: Mode 1 Radiation: Mode 1

Then, the EUT configuration and cable configuration of the above highest emission mode was chosen for all final test item

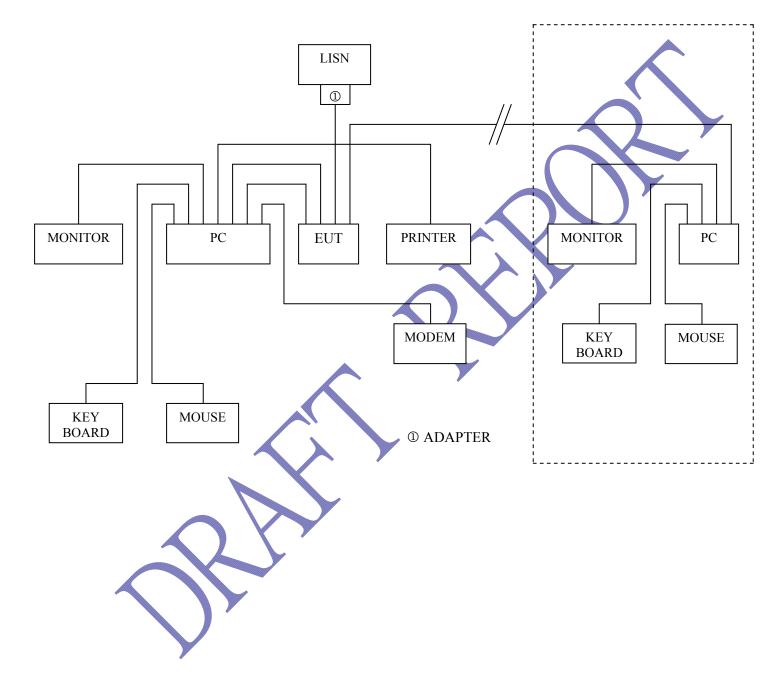
HARMONICS / FLICKER and EMS test mode is Mode 1



# **1.4 DESCRIPTION OF THE SUPPORT EQUIPMENTS**

## <u>Setup Diagram</u>

See test photographs attached in appendix 1 for the actual connections between EUT and support equipment.





# Support Equipment

Peripherals Devices:

	OUTSIDE SUPPORT EQUIPMENT						
No.	Equipment	Model	Serial No.	FCC ID/ BSMI ID	Trade name	Data Cable	Power Cord
1.	PC	A13	L3AB112	R33B65	IBM	Shielded 10M	Unshielded 1.8m
2.	PC	C79	L3G5275	R33B65	IBM	Shielded 1m	Unshielded 1.8m
3.	MONITOR	TFT22W90P SA	E9377JA000166	R33037	AOC	Shielded 1.8M	Unshielded 1.8m
4.	MONITOR	V22ECBF	3M6U07702009	R31282	TATUNG	Shielded 1.6M	Unshielded 1.8m
5.	PRINTER	РНОТО750	BDEK017629	/3872P011	EPSON	Shielded 1.8M	Unshielded 1.8M
6.	MODEM	2814	N/A	IFAXDM1414	ACEEX	Shielded RS232~1.2M	Unshielded 1.8M
7.	MOUSE	M-S34	HCA41700559	DEL211029/48 62A011	Logitech	Shielded 1.8M~PS2	N/A
8.	MOUSE	MO28UOL	44Q3831	R41108	Lenovo	Shielded 1.8M/USB	N/A
9.	KEY BOARD	RT7D00	TH-0332TR- 37171-16R-3087	AQ6-7D0080C OB/3892C595	DELL	Shielded 1.9M/PS2	N/A
10.	KEY BOARD	AS-KBAOO O	C0610230445	T3A002	ASUS	Shielded 1.4M/PS2	N/A
11.	USB storage	TS2GJFV30	156511-6400	DOC/ D33193	TRANSCEN D	Shielded 1M	N/A
12.	ADAPTER	AG2412-B	N/A	N/A	JENTEC	N/A	Unshielded 1.5M
	INSIDE SUPPORT EQUIPMENT						
No.	Equipment	Model	Serial No.	FCC ID/ BSMI ID	Trade name	Data Cable	Power Cord
1.	MAIN BOARD	MP-LN2U23 SL	N/A	N/A	N/A	Unshielded 0.2M	Unshielded 0.2M
2.	HDD	200G	4ND43KQD	D33027	Seagate	Unshielded 0.2M	Unshielded 0.2M

Note: All the above equipment/cable were placed in worse case position to maximize emission signals during emission test

**Grounding:** Grounding was in accordance with the manufacturer's requirement and conditions for the intended use.

1.5 FEATURES OF EUT: PLEASE REFER TO USER MANUAL OR PRODUCT SPECIFICATION.



# **2.** INSTRUMENT AND CALIBRATION

#### 2.1 MEASURING INSTRUMENT CALIBRATION

The measuring equipment utilized to perform the tests documented in the report has been calibrated once a year or in accordance with the manufacturer's recommendations, and is traceable to recognized national standards.

#### 2.2 TEST AND MEASUREMENT EQUIPMENT

The following list contains measurement equipment used for testing. The equipment conforms to the requirement of CISPR 16-1, ANSI C63.2 and. Other required standards.

Calibration of all test and measurement, including any accessories that may effect such calibration, is checked frequently to ensure the accuracy. Adjustments are made and correction factors are applied in accordance with the instructions contained in the respective.

	Conducted Emission Measurement					
Instrument	Manufacturer	Model No.	Serial No.	Calibration Due Date	Note	
EMC Test Receiver	R&S	ESCI	100438	Apr. 29. 2009		
LISN	SCHAFFNER	NNB41	03/10015	Sep. 23. 2009	For EUT	
LISN	EMCO	3825/2	9001-1589	Sep. 23. 2009	For Support Unit	
RF Cable	Huber+Suhner	RG223/U	001	May. 29. 2009		
50ohm Terminal	N/A	50Ω	QC-TM001	Sep. 24. 2011		
Impedance Stabilization	Teseq GmbH	ISN T8	23334	DEC. 20. 2009		
	Radi	ated Emission	Measuremen	t		
Instrument	Manufacturer	Model No.	Serial No.	Calibration Due Date	Note	
Test Receiver	AFJ	ER55R	55300508277	SEP. 21. 2009		
Bilog Antenna	SUNOL	JB1	A052204	OCT. 19. 2009		
Turn table	EMCO	2080	9508-1805	N/A		

# TABLE 1 LIST OF TEST AND MEASUREMENT EQUIPMENT



Controller	EMCO	2090	9804-1328	N/A	
Preamplifier	WIRELESS	FPA6592G	60017	SEP. 24. 2009	
Spectrum Analyzer	NEX	NS-265	5044006	AUG. 07. 2009	
RF Cable	Huber+Suhner	RG214/U	15M+8M-002	SEP. 22. 2009	
Thermo-Hygro meter	WISEWIND	4-INU-1	050100378	Apr. 08. 2009	
Р	ower Harmonic	Measuremen	t and Voltage	Fluctuations	
Instrument	Manufacturer	Model No.	Serial No.	Calibration Due Date	Note
5KV AC Power Source	SCHAFFNER	NSG1007	55869	DEC. 28. 2009	
Signal Conditioning	SCHAFFNER	CCN1000-1	72281	DEC. 28. 2009	
		EMS	S		
Instrument	Manufacturer	Model No.	Serial No.	Calibration Due Date	Note
		IEC61000	0-4-2		
Thermo-Hygro meter	WISEWIND	N/A	N/A	NOV. 02. 2010	
ESD Dimulator	SCHAFFNER	NSG435	N/A	OCT. 30. 2009	
		IEC61000	)-4-3		
Power Meter	BOONTON	4231A	110602	NOV. 13. 2009	
Signal Generator	IFR	2023A	202305/561	SEP. 06. 2009	
Electric Field probe	ETS-LINDGREN	HI-6005	00029837	MAY. 29. 2009	
Power Amplifier	SCHAFFNER	CBA9413B	4039	N/A	
Power Amplifier	SCHAFFNER	CBA 3G-050	T43762	N/A	
IEC61000-4-4/ IEC61000-4-5/ IEC61000-4-8/ IEC61000-4-11					
System Mainframe	SCHAFFNER	NSG2050	200339-277AR	OCT. 22. 2009	
		Page10/	4.1		



Pulse Coupling Network	SCHAFFNER	CDN131	34330	OCT. 22. 2009	
Fast Transient/Burst	SCHAFFNER	PNW2225	200404-515Lu	OCT. 22. 2009	
Dropout / Variation	SCHAFFNER	PNW2003	200321-502Lu	OCT. 22. 2009	
Impulse NETW 1,2/50-8/20 COMBWAVE	SCHAFFNER	PNW2050.8.	200413-503LU	OCT. 22. 2009	
Coil	SCHAFFNER	INA702	403-388/0411	N/A	
Clamp	SCHAFFNER	CDN8014	20607	N/A	•
TTIAXIAL ELF Magnetic Field Meter	SYPRIS	4090	4090070316	Apr. 08, 2009	
		IEC61000	-4-6		
RF-Generator	SCHAFFNER	NSG2070	NSG2070	OCT. 22. 2009	
CDN	SCHAFFNER	CDN M216	19286	OCT. 24. 2009	
CDN	SCHAFFNER	CDN M316	20653	OCT. 24. 2009	
Clamp	SCHAFFNER	KEMZ801	19806	OCT. 24. 2009	

X Calibration interval of instruments listed above is one year

# 2.3 TEST PERFORMED

Conducted emissions were invested over the frequency range from 0.15MHz to 30MHz using a receiver which resolution bandwidth is set at 9 KHz.

Radiated emissions were invested over the frequency range from 30MHz to 1000MHz using a receiver which resolution bandwidth is set at 120KHz. Radiated measurement was performed at distance that from an antenna to EUT is 10 meters.



# **2.4** APPENDIX

#### **Appendix A: Measurement Procedure for Main Power Port Conducted Emissions**

The measurements are performed in a Global lab's room; The EUT was placed on non-conductive 1.0m x 1.5m table, which is 0.8 meter above an earth-grounded.

Power to the EUT was provided through the LISN which has the Impedance (50ohm/50uH) vs. Frequency Characteristic in accordance with the standard. Powers to the LISNs were filtered to eliminate ambient signal interference and these filters were bonded to the ground plane. Peripheral equipment required to provide a functional system (support equipment) for EUT testing was powered from the second LISN through a ganged, metal power outlet box which is bonded to the ground plane at the LISN.

If the EUT is supplied with a flexible power cord, the power cord length in excess of the distance separating the EUT from the LISN shall be folded back and forth at the center of the lead so as to form a bundle not exceeding 40cm in length. If the EUT is provided with a permanently coiled power cord, bundling of the cord is not required. If the EUT is supplied without a power cord, the EUT shall be connected to the LISN by a power cord of the type specified by the manufacturer which shall not be longer than 1 meter. The excess power cord shall be bundled as described above. If a non-flexible power cord is provided with the EUT, it shall be cut to the length necessary to attach the EUT to the LISN and shall not be bundled.

The interconnecting cables were arranged and moved to get the maximum measurement. Both the line of power cord, hot and neutral, was measured.

The highest emissions were analyzed in details by operating the spectrum analyzer in fixed tuned mode to determine the nature of the emissions and to provide information which could be useful in reducing their amplitude.

# **Appendix B: Test Procedure for Radiated Emissions**

#### Preliminary Measurements in the Anechoic Chamber

The radiated emissions are initially measured in the anechoic chamber at a measurement distance of 3 meters. Desktop EUT are placed on a wooden stand 0.8 meter in height. The measurement antenna is 3 meters from the EUT. The test setup in anechoic chamber is the same as open site. The turntable rotated 360°. The antenna height is 1m. The primary objective of the radiated measurements in the anechoic chamber is to identify the frequency spectrum in the absence of the electromagnetic environment existing on the open test site. The frequencies can then be pre-selected on the open test site to obtain the corresponding amplitude. The initial scan is made with the spectrum analyzer in automatic sweep mode. The spectrum peaks are then measured manually to determine the exact frequencies.



#### Measurements on the Open Site or Chamber

The radiated emissions test will then be repeated on the open site or chamber to measure the amplitudes accurately and without the multiple reflections existing in the shielded room. The EUT and support equipments are set up on the turntable. Desktop EUT are set up on a wooden stand 0.8 meter above the ground.

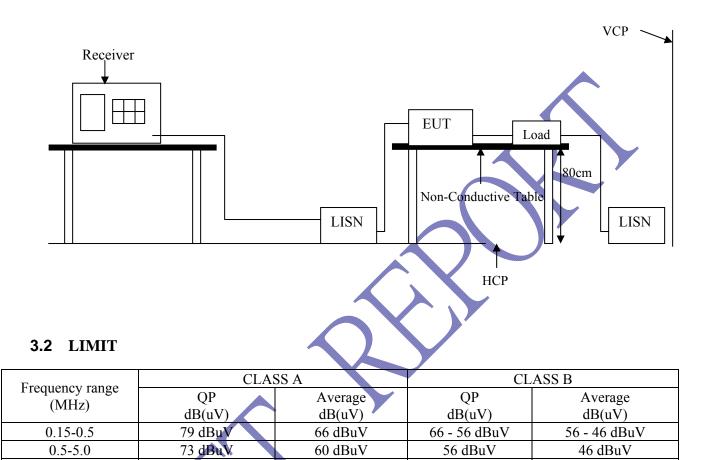
For the initial measurements, the receiving antenna is varied from 1-4 meter height and is changed in the vertical plane from vertical to horizontal polarization at each frequency. Both reading are recorded with the quasi-peak detector with 120 KHz bandwidth. For frequency between 30 MHz and 1000MHz, the reading is recorded with peak detector or quasi-peak detector.

At the highest amplitudes observed, the EUT is rotated in the horizontal plane while changing the antenna polarization in the vertical plane to maximize the reading. The interconnecting cables were arranged and moved to get the maximum measurement. Once the maximum reading is obtained, the antenna elevation and polarization will be varied between specified limits to maximize the readings.



# **3.** CONDUCTED EMISSION MEASUREMENT

# 3.1 TEST SET-UP



Remark: In the above table, the tighter limit applies at the band edges.

60 dBuV

# 3.3 TEST PROCEDURE

73 dBuV

5.0-30.0

The EUT and simulators are connected to the main power through a line impedance stabilization network (LISN). It provides a 50 ohm / 50  $\mu$ H coupling impedance for the measuring equipment. The peripheral devices are also connected to the main power through a LISN that provides a 50 ohm / 50  $\mu$ H coupling impedance with 50 ohm termination. (Please refer to the block diagram of the test setup and photograph.)

60 dBuV

50 dBuV

Both sides of AC line are checked for the maximum conducted emission interference. In order to find the maximum emissions, the relating positions of equipment and all of the interference cables must be changed according to EN 55022/2006 regulation: The measurement procedure on conducted emission interference.

The resolution bandwidth of the field strength meter is set at 9 KHz



#### **3.4 TEST SPECIFICATION**

According to EN 55022

(Please refers to Page 4 for dated references which are related to the standard as mentioned above)

#### **3.5 RESULT: PASSED**

EMI Receiver/Spectrum Analyzer Configuration (for the frequencies tested)

Frequency Range:	150KHz30MHz	
Detector Function:	Quasi-Peak / Average Mode	
Resolution Bandwidth:	9KHz	

#### **3.6 TEST DATA:**

Please refer to appendix 2



# **3.7** LIMIT OF CONDUCTED COMMON MODE DISTURBANCE AT TELECOMMUNICATION PORTS:

Frequency Range	Quasi Peak (dBuV)	Average
0.15 ~ 0.5 MHz	84 - 74	74 – 64
0.5 ~ 30 MHz	74	64

The limits decrease linearly with the logarithm of the frequency in the range 0.15 MHz to 0.5MHz for

Class B.

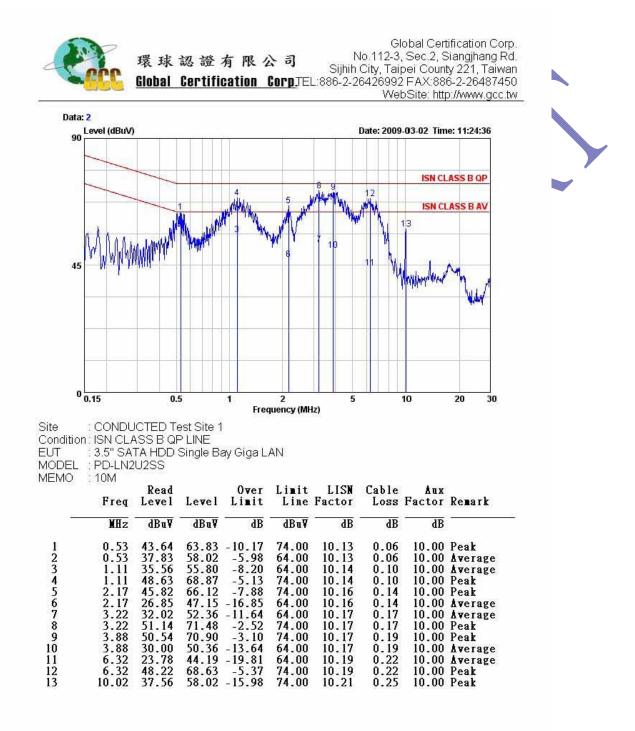
#### REMARK:

- 1. Model: PD-LN2U2SS, IB-NAS4210-B
- 2. Measuring mode: 1.1000Mbps, 2.10Mbps, 3.10Mbps
- 3. The Worst Mode: 3.10Mbps
- 4. Deviations from the test standards and rules: None.
- 5. "\*", means this data is peak measuring as peak value is under Q.P. Limit or Average Limit 3dB margin.
- 6. Result : PASSED



Date of Issue: Mar. 03, 2009 Report No.: E922504

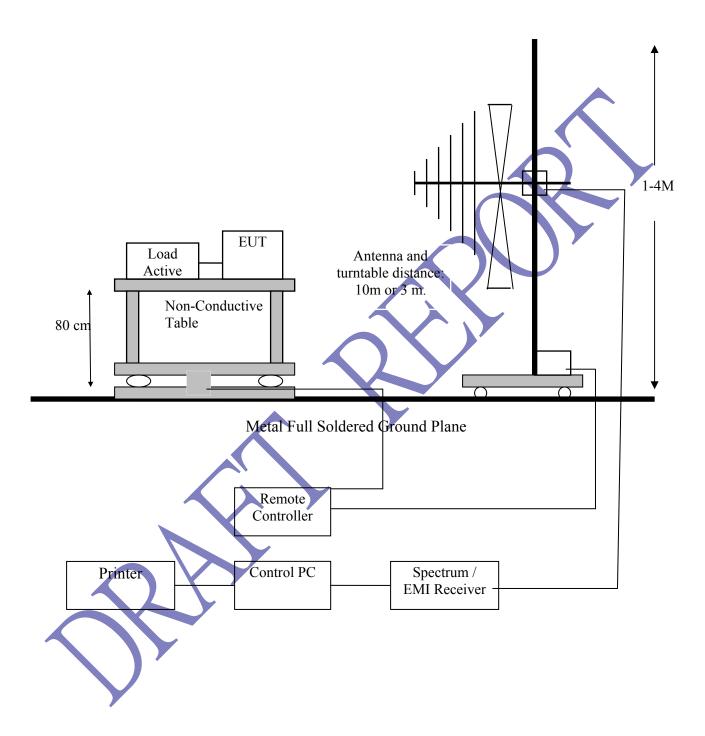
# **3.8** RESULT OF CONDUCTED COMMON MODE DISTURBANCE AT TELECOMMUNICATION PORTS





# 4. RADIATED EMISSION MEASUREMENT

# 4.1 TEST SETUP





#### **4.2** LIMIT

Frequency	Class A		C	lass B
MHz	Distance (Meter)	Limit dBµV/m	Distance (Meter)	Limit dBµV/m
30~230	10	40	10	30
230 ~ 1000	10	47	10	37

Remark: In the above table, the tighter limit applies at the band edges

#### 4.3 TEST PROCEDURE

The EUT and its simulators are placed on turn table, non-conductive and wooden table, which is 0.8 meter above ground. The turn table rotates 360 degrees to determine the position of the maximum emission level. The EUT was positioned such that distance from antenna to the EUT is 10 meters.

The antenna is moved up and down between 1 meter to 4 meters to receive the maximum emission level.

Both horizontal and vertical polarizations of the antenna are set on measurement. In order to find the maximum emission, all of the interference cables must be manipulated according to EN 55022/1998 regulation: the test procedure of the radiated emission measurement.

The bandwidth set on the field strength is 120 KHz when the frequency range is below 1GHz

## 4.4 TEST SPECIFICATION

According to EN 55022

(Please refers to Page 4 for dated references which are related to the standard as mentioned above)

## 4.5 RESULT: PASSED

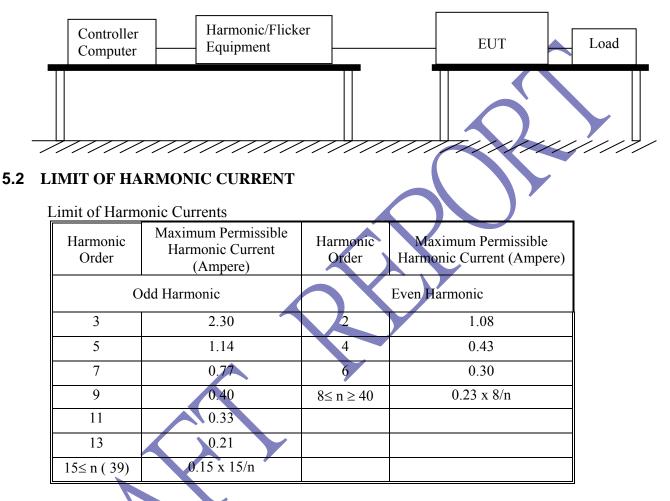
4.6 TEST DATA:

Please refer to appendix 2



# **5. POWER HARMONIC MEASUREMENT**

## 5.1 TEST SETUP



# 5.3 TEST PROCEDURE

The EUT is supplied in series with power analyzer from a power source has the same normal voltage and frequency as the rated supply voltage and the equipment under test. The rated voltage at the supply voltage of EUT of 0.94 time and 1.06 times shall be performed.

# 5.4 TEST SPECIFICATION

According to EN 61000-3-2

(Please refers to Page 4 for dated references which are related to the standard as mentioned above)

#### 5.5 RESULT: PASSED

**5.6 TEST DATA:** 



# Harmonics – Class-D per Ed. 3.0 (2005-11) (Run time)

EUT: 3.5" SATA HDD Single Bay Giga LAN Tested by: Anson Test category: Class-D per Ed. 3.0 (2005-11) (European limits) Test Margin: 100 Test date: 2009/3/2 Comment: PD-LN2U2SS Customer: 922504

Test Result: N/L Source qualification: Normal Current & voltage waveforms 0.3 300 200 0.2 Voltage (Volts) Current (Amps) 0.1 100 0.0 0 -0.1 -100 -0.2 -200 -0.3 -300 Harmonics and Class D limit line **European Limits** 0.025 Current RMS(Amps) 0.020 0.015 0.010 0.005 0.000 8 20 24 32 36 40 4 12 16 28 Harmonic #

Test result: N/L Worst harmonic was #0 with 0.00% of the limit.



# **Current Test Result Summary (Run time)**

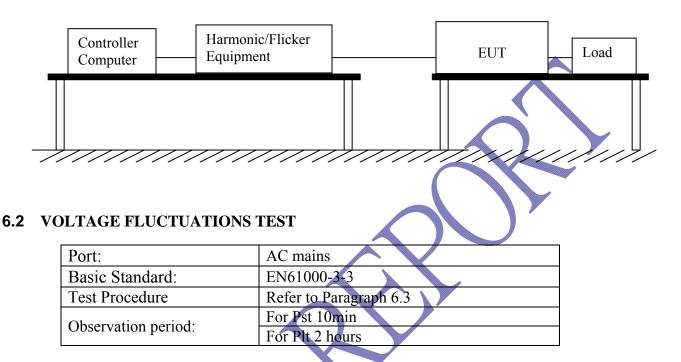
Test ca Test da Comme	EUT: 3.5" SATA HDD Single Bay Giga LAN Tested by: Anson Test category: Class-D per Ed. 3.0 (2005-11) (European limits) Test Margin: 100 Test date: 2009/3/2 Comment: PD-LN2U2SS Customer: 922504						
THC(A)	sult: N/L : 0.00 I-TH t parameter va	Source qua D(%): 0.00 alues during	POHC(A		HC Limit(A):	0.000	
	V_RMS (Volts			Frequency(Hz)	: 50.00		$\frown$
	I_Peak (Amps			I_RMS (Amps)			
	Fund (Amp			Crest Factor:	5.232		
	Power (Watts			Power Factor:	0.368		
		,			01000		
Harm#	Harms(avg)	100%Limit	%of Limit	Harms(max)	150%Limit	%of Limit	Status
2	0.001						
3	0.021	0.017	0.0	0.021	0.026	0.00	N/L
4	0.001	0.017	0.0	0.021	0.020	0.00	
	0.020	0.010	0.0	0.021	0.014	0.00	N/L
5 6 7	0.020	0.010	0.0	0.021	0.014	0.00	
0 7		0.005	0.0	0.000	0.000	0.00	N1/I
1	0.020	0.005	0.0	0.020	0.008	0.00	N/L
8	0.001						
9	0.019	0.003	0.0	0.019	0.004	0.00	N/L
10	0.001						
11	0.017	0.002	0.0	0.017	0.003	0.00	N/L
12	0.001						
13	0.016	0.002	0.0	0.016	0.002	0.00	N/L
14	0.000						
15	0.014	0.001	0.0	0.014	0.002	0.00	N/L
16	0.000						
17	0.013	0.001	0.0	0.013	0.002	0.00	N/L
18	0.000						
19	0.011	0.001	0.0	0.011	0.002	0.00	N/L
20	0.000				0.002	0.00	=
21	0.009	0.001	0.0	0.010	0.001	0.00	N/L
22	0.000			0.010	0.001	0.00	14/ 1
23	0.008	0.001	0.0	0.008	0.001	0.00	N/L
24	0.000		0.0	0.000	0.001	0.00	IN/ L
25	0.006	0.001	0.0	0.006	0.001	0.00	N/L
26	0.000	0.001	0.0	0.000	0.001	0.00	
20	0.000	0.001	0.0	0.005	0.001	0.00	N/L
		0.00	0.0	0.005	0.001	0.00	IN/L
28	0.000	0.004	0.0	0.004	0.004	0.00	N1/I
29	0.003	0.001	0.0	0.004	0.001	0.00	N/L
30	0.000			0.000	0.004	0.00	N1/I
31	0.002	0.001	0.0	0.003	0.001	0.00	N/L
32	0.000						
33	0.002	0.001	0.0	0.002	0.001	0.00	N/L
34	0.000		_				
35	0.001	0.001	0.0	0.001	0.001	0.00	N/L
36	0.000						
37	0.001	0.001	0.0	0.001	0.001	0.00	N/L
38	0.000						
39	0.001	0.001	0.0	0.001	0.001	0.00	N/L
40	0.000						

Note: The EUT power level is below 75.0 Watts and therefore has no defined limits



# 6. VOLTAGE FLUCTUATIONS

#### 6.1 TEST SETUP



#### 6.3 TEST PROCEDURE

The EUT is supplied in series with reference impedance from a power source with the voltage and frequency as the nominal supply voltage and frequency of the EUT.

## 6.4 TEST SPECIFICATION

EN 61000-3-3

(Please refers to Page 4 for dated references which are related to the standard as mentioned above)

# 6.5 RESULT: PASSED

TEST DATA

6.6



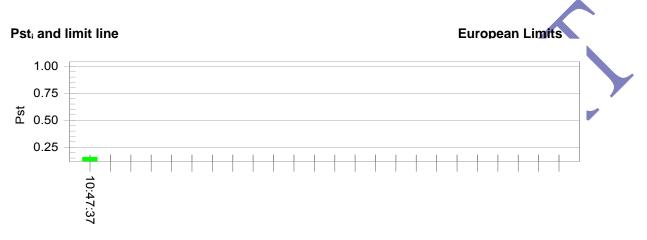
# Flicker Test Summary per EN/IEC61000-3-3 (Run time)

EUT: 3.5" SATA HDD Single Bay Giga LAN Test category: All parameters (Éuropean limits) Test date: 2009/3/2 Comment: PD-LN2U2SS Customer: 922504

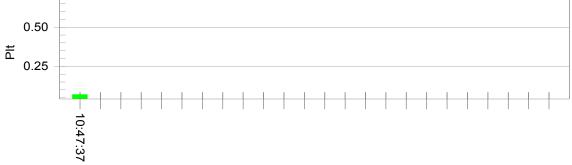
**Tested by: Anson** Test Margin: 100

**Test Result: Pass** 

Status: Test Completed







Parameter values recorded during the test: Vrms at the end of test (Volt): 229.37 Highest dt (%): 0.00 Time(mS) > dt: 0.0 Highest dc (%): 0.00 Highest dmax (%): Highest Pst (10 min. period): Highest Plt (2 hr. period): 0.00 0.160

0.070

Test limit (%):	3.30	Pass
Test limit (mS):	500.0	Pass
Test limit (%):	3.30	Pass
Test limit (%):	4.00	Pass
Test limit:	1.000	Pass
Test limit:	0.650	Pass



# 7. ELECTROSTATIC DISCHARGE IMMUNITY TEST (ESD)

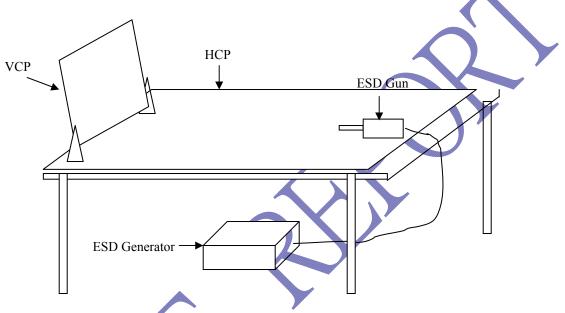
# 7.1 TEST PROCEDURE

According To IEC 61000-4-2

According To EN 55024

(Please refers to Page 4 for dated references which are related to the standard as mentioned above)

# 7.2 TEST SETUP



## 7.3 TEST LEVEL

Item	Test Specification	Unit	Performance Criteria
	±2, 4, 8 (Air Discharge)	KV	В
Electrostatic Discharge	±2,4 (Contact Discharge)	(Charge Voltage)	D
Time between test	<u>1</u>	sec	

Number of test: <u>10</u> Discharges / Test point / Polarity / Level

Particular requirements: at least 200 discharges, 100 each at negative and positive polarity, at a minimum of four test points.

When the measurement was taken, The ESD discharger was performed in single discharge. For the single discharge time between successive single discharges will keep on one second. It was at least ten single discharges with positive and negative at the same selected pointed. The selected pointed, which was performed with electrostatic discharge, was marked on the red label on the EUT

Indirect applicant of discharge to the EUT

Vertical Coupling Plane (VCP)



The coupling plane, of dimensions  $0.5m \ge 0.5m$ , is placed parallel to, and positioned at a distance 0.1m from, the EUT, with the discharge electrode touching the coupling plane.

The four faces of the EUT will be performed with electrostatic discharge. It was at least ten singles discharges with positive and negative at the same selected point.

Horizontal Coupling Plane (HCP)

The coupling plane is placed under the EUT. The generator shall be positioned vertically at a distance of 0.1m from the EUT, with the discharge electrode touching the coupling.

The four faces of the EUT will be performed with electrostatic discharge. It was at least ten single discharges with positive and negative at the same selected pointed.

#### 7.4 TEST RESULT.

Model: PD-LN2U2SS

Mode: USB

Temperature:  $20^{\circ}$ , Humidity: 55 % RH

Test Point	Air	Contact	Performance	Result
	Discharge	Discharge	Criteria	
НСР		±2, 4KV	В	PASSED
VCP		±2,4KV	В	PASSED
CASE	±2, 4, 8KV	±2, 4KV	В	PASSED
I/O PORTS	±2, 4, 8KV	±2, 4KV	В	PASSED
LED	±2, 4, 8KV	±2, 4KV	В	PASSED
SCREWS	±2, 4, 8KV	±2, 4KV	В	PASSED
DC SOCKET	±2, 4, 8KV	±2, 4KV	В	PASSED
BUTTON	±2, 4, 8KV	±2, 4KV	В	PASSED

Final Result: **PASSED** 

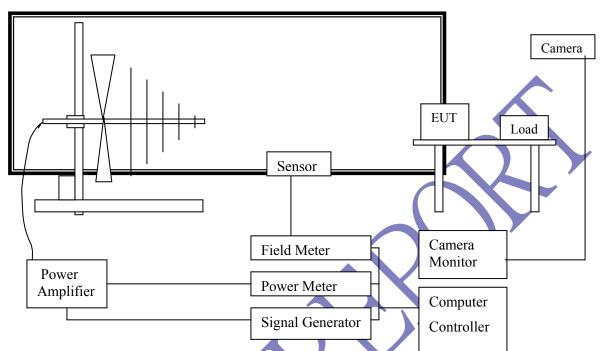
Remark: During the test, the data packages are stops to write and read. After the test, EUT resume automatically.

Photos of test configuration please refer to appendix 1.



#### **8.** RADIATED EMISSION MEASUREMENT (RS)

## 8.1 TEST SETUP



# 8.2 TEST PROCEDURE

According To IEC 61000-4-3

According To EN 55024

(Please refers to Page 4 for dated references which are related to the standard as mentioned above)

# 8.3 TEST LEVEL

Item	Test Specification	Unit	Performance Criteria
Radio – Frequency	80~1000	MHz	А
Electromagnetic Field	3	V/m (unmodulated, rms)	
Amplitude Modulated	80	%AM (1KHz)	



#### **8.4 TEST PROCEDURE**

The EUT and load, which are placed on a wooden table that the height is 0.8 meter above ground, are placed with one coincident with the calibration plane such that the distance from antenna to the EUT is 3 meters.

Both horizontal and vertical polarization of the antenna position and four sides of the EUT are set on measurement. In order to judge the EUT performance, a CCD camera is used to monitor the situation of EUT.

ŀ	<b>A</b> 11	the scanning	conditions are	e as follows:	

Condition of Test	Remarks
1. Field Strength	3 V/M; Level 2
2. Radiated Signal	AM 80% modulated with 1KHz
3. Scanning Frequencies	80MHz ~ 1000MHz
4. Dwell Time	3 seconds
5. Frequency step size	1%
6. The rate of swept of frequency	$1.5 \times 10^{-3}$ decades/s
7. Antenna Polarity	HORIZONTAL & VERTICAL
8. The four sides of EUT are tested	FRONT, REAR, RIGHT, LEFT

## 8.5 TEST RESULT

Model: PD-LN2U2SS

Mode: USB

Temperature: <u>20°C</u> , Humidity: <u>55</u> % RH

ANT SIDE	3V HORIZONTAL	3V VERTICAL	RESULT
FRONT	A	А	PASSED
REAR	A	А	PASSED
RIGHT	А	А	PASSED
LEFT	А	А	PASSED

Final Result: PASSED

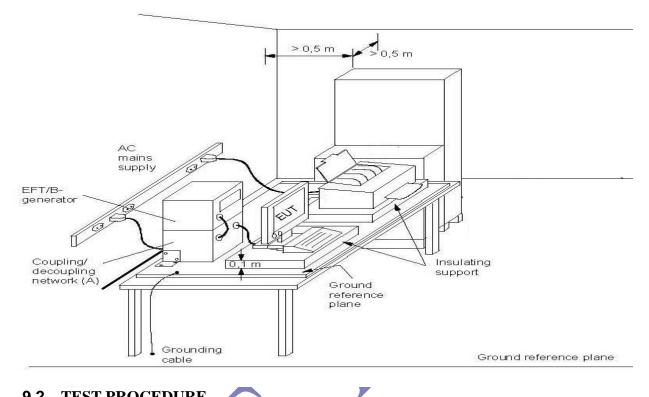
Remark:

Photos of test configuration please refer to appendix 1.



#### 9. ELECTRICAL FAST TRANSIENT/BURST (EFT)

#### 9.1 **TEST SETUP**



#### 9.2 **TEST PROCEDURE**

According To IEC 61000-4

According To EN 55024

(Please refers to Page 4 for dated references which are related to the standard as mentioned above)

#### 9.3 **TEST PROCEDURE**

The EUT and load are placed on a ground reference plane and insulated from it by an insulating support 0,1 m  $\pm$  0,01 m thick. The minimum area of the ground reference plane is 1 m  $\times$  1 m. It also projected beyond the EUT by at lease 0.1 meter on all sides.

For Input and Output AC power or DC Input and DC Output Power Ports:

The EUT is connected with the power mains through a coupling device that directly couples the SFT interference signal.

Each of the line and nature conductors is impressed with burst noise for 1 minute. For Protective Earth Port:

The EUT is connected to the power mains through a coupling device that directly couples the EFT interference signal. The protective earth line (PE) is impressed with burst noise for 1 minute.

The length of power cord between the coupling device and the EUT shall be  $0.5 \text{ m} \pm 0.05 \text{ m}$ . For signal Lines and Control Lines Test:

The EFT interference signal is through a coupling clamp device couples to the signal and control lines of the EUT with burst noise for 1 minute.



# 9.4 TEST LEVEL

Item	Test Specification	Unit	Performance Criteria
Test Voltage	$\pm 0.5, \pm 1$	KV (Peak)	В
Pulse Rise time & Duration	5/50	Tr/Ts (ns)	
Pulse Repetition	5	Rep. Frequency (KHz)	
Coupling of power line	L, N, PE, L+N, L+	PE, N+PE, L+N+PE	$\frown$

# 9.5 TEST RESULT

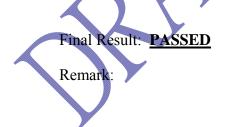
Model: PD-LN2U2SS

Mode: USB

Temperature:  $20^{\circ}$ , Humidity: 55 % RH

Power Line				
TEST VOLTAGE	L	Ν	L+N	
±0.5KV	A	A	А	
±1KV	A	Ā	А	

Signal Control Line		
TEST VOLTAGE	Performance Criteria	
±0.25KV	А	
±0.5KV A		

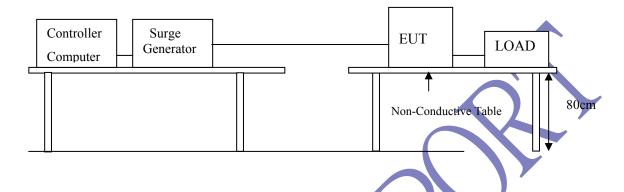


Photos of test configuration please refer to appendix 1.



# **10.** SURGE

#### **10.1 TEST SETUP**



# **10.2 TEST PROCEDURE**

According To IEC 61000-4-5

According To EN 55024

(Please refers to Page 4 for dated references which are related to the standard as mentioned above)

## **10.3 TEST LEVEL**

Item	Test Specification	Unit	Performanc Criteria
DC Input and DC Output Power Ports			
Surge	1.2/50(8/20)	Tr/Ts (µs)	В
Line to Ground	±0.5	KV	
Line to Line	±0.5	KV	
AC Input and AC Output Power Ports			
Surge	1.2/50(8/20)	Tr/Ts (µs)	В
Line to Ground	±2	KV	
Line to Line	±1	KV	
Polarity	POSITIVE / NEGATI	VE	
Phase shifting in a range between 0° to 360	0		



#### **10.4 TEST PROCEDURE**

The EUT and its load are placed on a table which is 0.8 meter height. The length of power cord between the coupling device and the EUT shall be 2 meters or less.

For Input and Output AC Power or DC Input and DC Output Power Ports:

The EUT is connected to the power mains through a coupling device that directly couples the Surge interference signal.

The Surge noise shall be applied synchronized to the voltage phase at 0°, 90 °, 180°, 270 ° and the peak value of the AC voltage wave. (5 Positive and 5 Negative)

Each of line-earth and line-line is impressed with a sequence of five surge voltages with interval of 1 minute.

#### **10.5 TEST RESULT**

Model: PD-LN2U2SS

Mode: USB

Temperature: <u>20°C</u> , Humidity: <u>55</u>

Environmental Phenomena	Test Specification	Units	Performance Criteria
Line to Line	±1	KV (Charge Voltage)	А

% RH

Final Result: PASSED

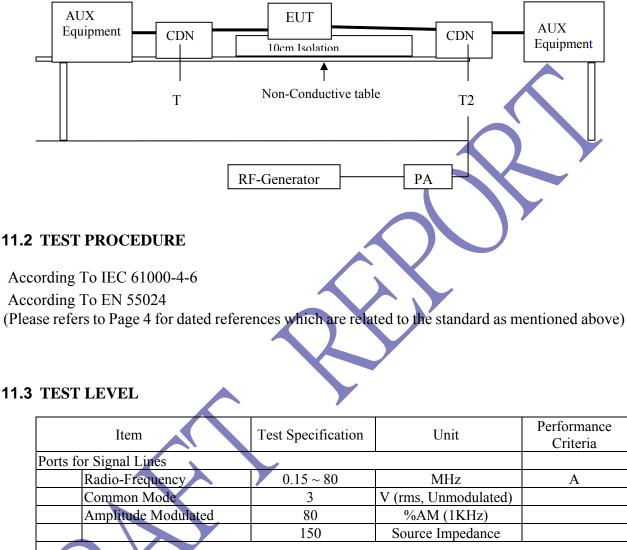
Remark:

Photos of test configuration please refer to appendix 1.



# 11. IMMUNITY TEST TO CS CONDUCTED DISTURBANCE (CS)

# **11.1 TEST SETUP**



Ac Input and AC Output and DC Input and DC output Ports and Functional Earth Ports					
	Radio-Frequency	0.15 ~ 80	MHz		
	Common Mode	3	V (rms, Unmodulated)	А	
	Amplitude Modulated	80	%AM (1KHz)		
		150	Source Impedance		

## **11.4 TEST PROCEDURE**

The EUT are placed on a table which is 0.8meter height and a ground reference plane on the table, the EUT are placed upon table and use 10cm insulation between the EUT and ground reference plane.

For AC Input and AC Output Power or DC Input and DC Output Power Ports The EUT is connected to the power mains through a coupling and decoupling networks for Power supply lines. It also directly couples the disturbance signal into EUT.



Use CDN-M2 for two wires or CDN-M3 for three wires.

For Signal Lines and Control Lines Test:

The disturbance signal is through a coupling and decoupling networks (CDN) or EM-clamp which is to couple the signal and control lines of the EUT.

All scanning frequencies conditions are as following:

Condition of Test	Remarks
EN 61000-4-6/2007	
1. Field Strength	3 V/M; Level 2
2. Radiated Signal	AM 80% modulated with 1KHz
3. Scanning Frequencies	0.15MHz ~ 80MHz
4. Dwell Time	3 seconds
5. Frequency step size $\Delta f$	1%
6. The rate of swept of frequency	$1.5 \times 10^{-3}$ decades/s

RH

## **11.5 TEST RESULT**

#### Model: PD-LN2U2SS

Mode: USB

Temperature: <u>20°C</u> , Humidity:

TEST Specification	Unit	Performance Criteria
0.15 - 80	MHz	
3	V	А
80	% AM (1KHz)	

Final Result: PASSED

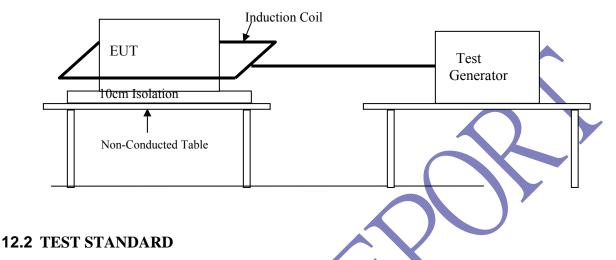
Remark:

# Photos of test configuration please refer to appendix 1.



# **12.** POWER FREQUENCY MAGNETIC FIELD (MAGNETIC)

# **12.1 TEST SETUP**



# According To IEC 61000-4-8

According To EN 55024

(Please refers to Page 4 for dated references which are related to the standard as mentioned above)

#### **12.3 TEST LEVEL**

Item	Test Specification	Unit	Performance Criteria
Power-Frequency	50	Hz	А
Magnetic Field	1	A/M	

# **12.4 TEST PROCEDURE**

The EUT and its load are placed on a table that is 0.8 meter above the metal ground plane dimension is at least 1 meter x 1 meter. The test magnetic field shall be placed at least than 3 meter distance from the induction coil.

The test magnetic field shall be applied by the immersion method to the EUT. The induction coil shall be rotated by  $90^{\circ}$  in order to expose the EUT to the test field with different orientation (X, Y, Z orientation).



## **12.5 TEST RESULT**

Model: PD-LN2U2SS

Mode: USB

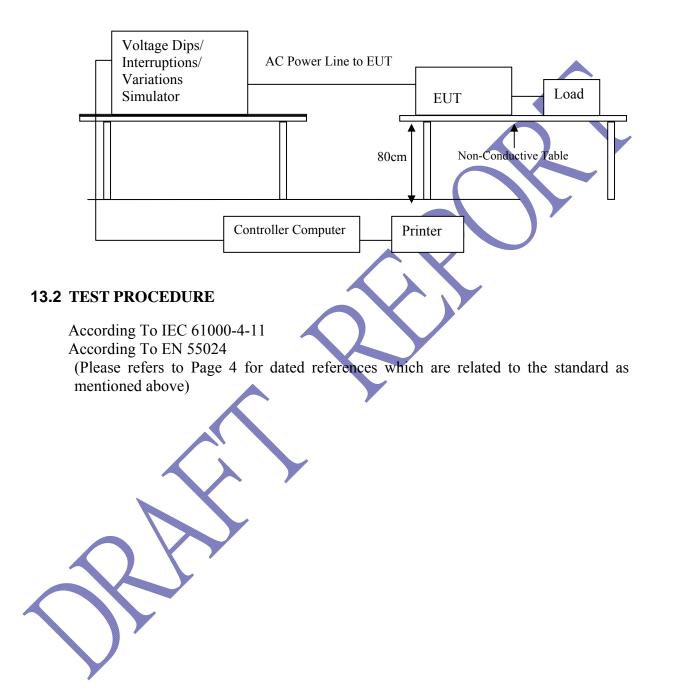
Temperature:  $20^{\circ}$ , Humidity: 55 % RH

Environmental Phenomena	Test Specification	Units	Performance Criteria
Magnetic Field	1	A/m	
Final Result: <b>PASS</b> Remark: <b>Photos of test conf</b>	SED iguration please refer to a	appendix 1.	



# **13.** VOLTAGE DIPS AND INTERRUPTION MEASUREMENT

# **13.1 TEST SETUP**





# **13.3 TEST LEVEL**

Class <sup>a</sup>	Test level and durations for voltage dips					
Class 1	C	Case-by-case according to the equipment requirements				
Class 2	0 % during	0 % during	70 % during 25/30 <sup>c</sup> cycles			
Class 2	1/2 cycle	1 cycle				
Class 2	0 % during	0 % during	40 % during	70 % during	80 % during	
Class 3	1/2 cycle	1 cycle	$10/12^{\rm c}$ cycles	$25/30^{\circ}$ cycles	250/300 <sup>c</sup> cycles	
Class X <sup>b</sup>	Х	Х	Х	Х	X	
a: Classes as per IEC 61000-2-4.						
b: To be defined by product committee. For equipment connected directly or indirectly						
to the pu	blic network,	the levels mus	st not be less seve	ere than Class 2.		

c: "25/30 cycles" means "25 cycles for 50 Hz test" and "30 cycles for 60 Hz tet"

Class <sup>a</sup>	Test level and durations for short interruptions $(t_s)$ (50Hz/60Hz)
Class 1	Case-by-case according to the equipment requirements
Class 2	0 % during 250/300 <sup>c</sup> cycles
Class 3	0 % during 250/300 <sup>e</sup> cycles
Class X <sup>b</sup>	

a: Classes as per IEC 61000-2-4.

b: To be defined by product committee. For equipment connected directly or indirectly to the public network, the levels must not be less severe than Class 2.

c: "250/300 cycles" means "250 cycles for 50 Hz test" and "300 cycles for 60 Hz test".

# **13.4 TEST PROCEDURE**

The EUT and its load are placed on a wooden table which is 0.8 meter above a metal ground plane which dimension is 1 meter x 1 meter, the thickness is 0.65mm. It projected beyond the EUT by at least 0.1 meter on all sides. The power cord shall be used the shortest power cord as specified by the manufacturer.

For Voltage Dips / Interruption Test:

The EUT is connected to the power mains through a coupling device that directly couples to the Voltage Dips and Interruption Generator.

The EUT shall be tested for 30% voltage dips of supplied voltage and duration time is 10ms, for 60% voltage dips of supplied voltage and duration time is 100ms with a sequence of three voltage dips with intervals of 10 seconds, and for 95% voltage interruption of supplied voltage and the duration time is 5000ms with a sequence of three voltage interruptions with intervals of 10 seconds.

Voltage phase shifting are shall occur at 0°, 45 °, 90 °, 135 °, 180 °, 225 °, 270 °, 315 ° of the voltage.



# **13.5 TEST RESULT**

Model: PD-LN2U2SS

Mode: USB

Temperature:  $20^{\circ}$ , Humidity: 55 % RH

ſ	1		
Environmental	Test Specification	Units 🔨	Performance
Phenomena	1		Criteria
	0 1/2	% during Cycle	X
Voltage Dips	70	% during	С
	25	Cycles	C
Voltage Short	0	% during	C
Interruptions	250	Cycles	C

Final Result: **PASSED** 

Remark:

Photos of test configuration please refer to appendix 1.



# **14. PERFORMANCE CRITERIA**

- A. The apparatus shall continue to operate as intended during and after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended.
- B. The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- C. Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls.



# **15.** MODIFICATION LIST FOR EMC COMPLYING TEST

The modification is solely made by the applicant. Appendix Appendix A: Summary of Test Result

\*\*\*\* EMC Test Result: The EUT has been passed the all measurements. \*\*\*\*

The uncertainty is calculated in accordance with CISPR16-4-2, the total uncertainty for this test is as follows:

Uncertainty of Conducted Emission Measurement

Contribution	Probability Distribution	150KHz – 30MHz
Receiver reading	Normal (k=2)	±0.3
Cable loss	Normal (k=2)	±0.2
AMN insertion loss	Rectangular	±0.3
RCV/SPA specification	Rectangular	±0.1
combined standard uncertainty Ue(y)	normal	±0.5
Measuring uncertainty for a level of confidence of 95% U=2Ue(y)	normal (k=2)	±1.0

# Uncertainty of Radiated Emission Measurement

Contribution 🗼	Probability Distribution	30MHz~1GHz
Receiver reading	Normal (k=2)	±0.3
Cable loss calibration	Normal (k=2)	±0.3
Antenna factor calibration	Rectangular	±0.9
Pre Amplifier Gain calibration	Rectangular	±0.3
RCV/SPA specification	Rectangular	±0.2
combined standard uncertainty Ue(y)	normal	±1.0
Measuring uncertainty for a level of confidence of 95% U=2Ue(y)	normal (k=2)	±2.0

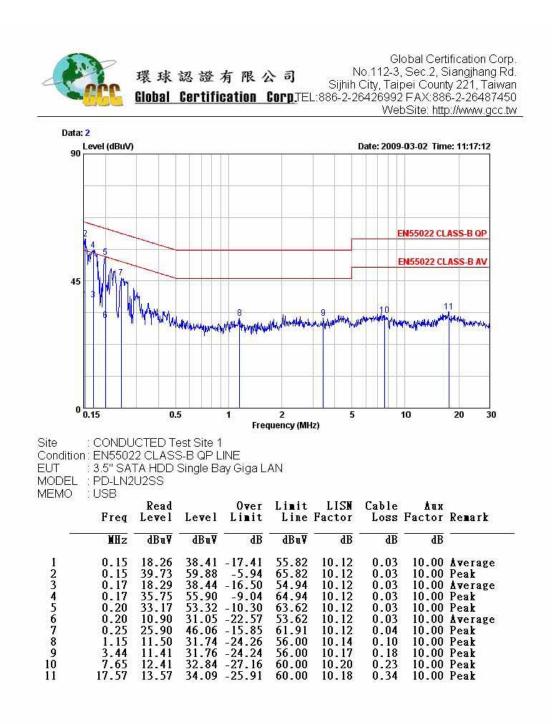


Appendix 2 TEST DATA



Report No. : E922504

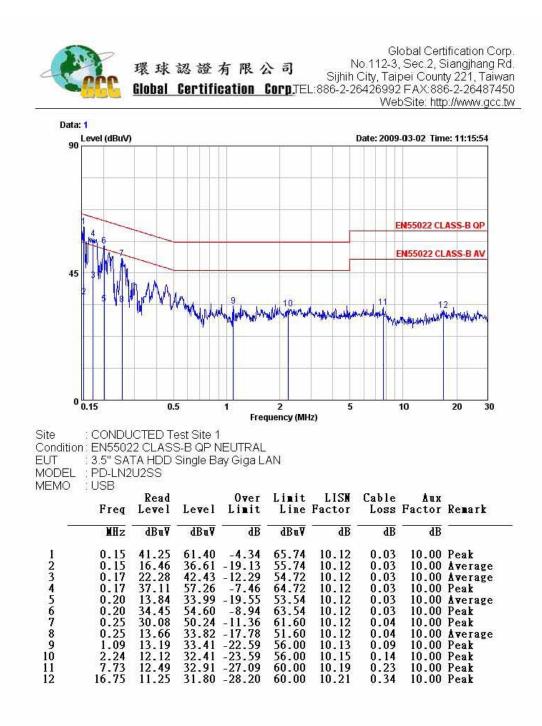
Test Data Of Conducted Emission Measurement (LINE)





Report No. : E922504

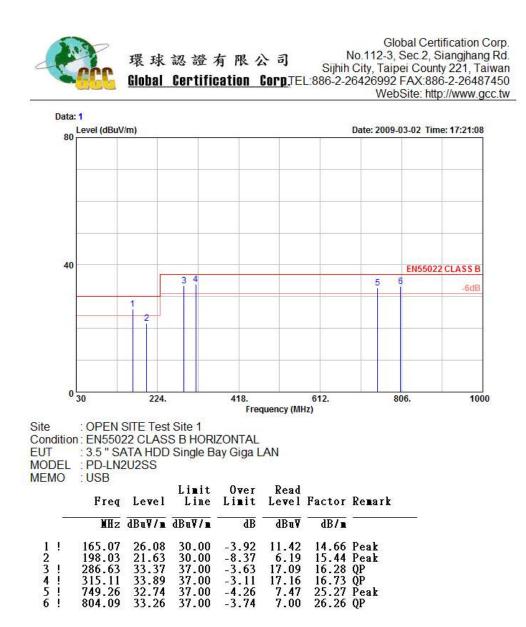
Test Data Of Conducted Emission Measurement (NATURAL)





Report No. : E922504

Test Data Of Radiated Emission Measurement (Horizontal)

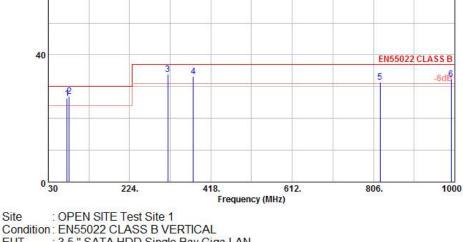




Report No. : E922504

Test Data Of Radiated Emission Measurement (Vertical)





Condition	I. LINJJUZZ OLA	NOOD VLINI	IUAL	
EUT	: 3.5 " SATA HE	DD Single Ba	y Giga L	AN
MODEL	: PD-LN2U2SS		53 8 <b>7</b> 5	
MEMO	: USB			
		T 2 2	0	D

		Freq	Level	Limit Line	Over Li∎it	Read Level	Factor	Remark
	256	MHz	dBuV/m	dBuV/m	dB	dBuV	dB/m	
1	Į.	74.66	26.34	30.00	-3.66	16.74	9.60	QP
23	Ι.	79.73	26.98	30.00	-3.02	17.46	9.52	QP
3	Ι.	315.09	33.91	37.00	-3.09	17.18	16.73	<b>OP</b>
45	Ţ.	375.78	33.22	37.00	-3.78	14.99	18.23	Peak
5	Ţ.	821.61	31.39	37.00	-5.61	4.92	26.47	Peak
6	1	990.65	32.35	37.00	-4.65	3.71	28.64	Peak